Silicon N-Channel MOS FET

HITACHI

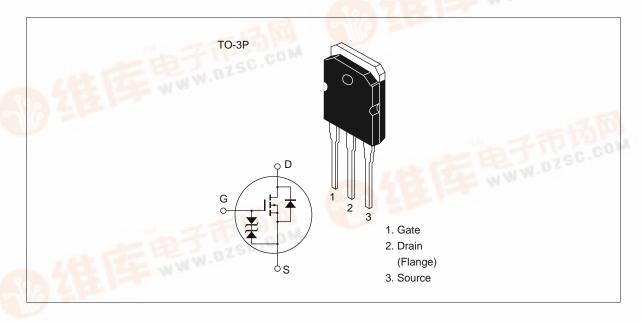
Application

High speed power switching

Features

- Low on-resistance
- High speed switching
- Low drive current
- No secondary breakdown
- Suitable for switching regulator and DC-DC converter

Outline





Absolute Maximum Ratings $(Ta = 25^{\circ}C)$

Item		Symbol	Ratings	Unit	
Drain to source voltage	2SK1163	V _{DSS}	450	V	
	2SK1164		500		
Gate to source voltage		V_{GSS}	±30	V	
Drain current		I _D	11	А	
Drain peak current		I _{D(pulse)} *1	40	Α	
Body to drain diode reverse	e drain current	I _{DR}	11	Α	
Channel dissipation		Pch*2	100	W	
Channel temperature		Tch	150	°C	
Storage temperature		Tstg	-55 to +150	°C	

Notes: 1. PW \leq 10 μ s, duty cycle \leq 1%

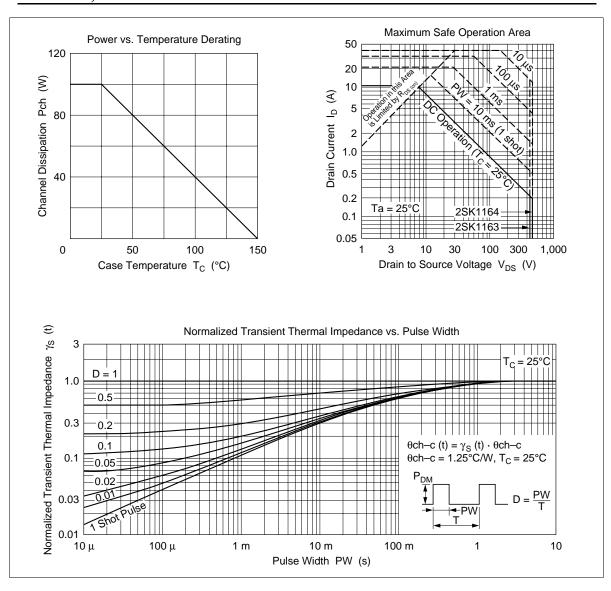
2. Value at $T_c = 25^{\circ}C$

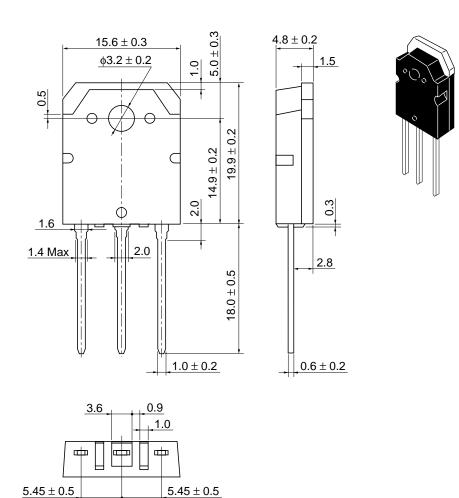
Electrical Characteristics ($Ta = 25^{\circ}C$)

Item		Symbol	Min	Тур	Max	Unit	Test conditions
Drain to source	2SK1163	$V_{(BR)DSS}$	450	_	_	V	$I_{D} = 10 \text{ mA}, V_{GS} = 0$
breakdown voltage	2SK1164	-	500	-			
Gate to source breakdown voltage		$V_{(BR)GSS}$	±30	_	_	V	$I_G = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current		I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0$
Zero gate voltage	2SK1163	I _{DSS}	_	_	250	μΑ	V _{DS} = 360 V, V _{GS} = 0
drain current	2SK1164						$V_{DS} = 400 \text{ V}, V_{GS} = 0$
Gate to source cutoff	voltage	$V_{\text{GS(off)}}$	2.0	_	3.0	V	$I_{D} = 1 \text{ mA}, V_{DS} = 10 \text{ V}$
Static Drain to source	2SK1163	R _{DS(on)}	_	0.55	0.7	Ω	$I_D = 5 \text{ A}, V_{GS} = 10 \text{ V}^{*1}$
on state resistance	2SK1164		_	0.60	8.0		
Forward transfer adm	ittance	yfs	5.0	8.0	_	S	$I_D = 5 \text{ A}, V_{DS} = 10 \text{ V}^{*1}$
Input capacitance		Ciss	_	1150	_	pF	$V_{DS} = 10 \text{ V}, V_{GS} = 0,$
Output capacitance		Coss	_	340	_	pF	f = 1 MHz
Reverse transfer capacitance		Crss	_	55	_	pF	-
Turn-on delay time		t _{d(on)}	_	17	_	ns	$I_D = 5 \text{ A}, V_{GS} = 10 \text{ V},$
Rise time		t _r	_	60	_	ns	$R_L = 6 \Omega$
Turn-off delay time		$t_{d(off)}$	_	95	_	ns	-
Fall time		t _f	_	50	_	ns	-
Body to drain diode for voltage	orward	V_{DF}	_	1.0	_	V	I _F = 11 A, V _{GS} = 0
Body to drain diode re recovery time	everse	t _{rr}	_	400	_	ns	$I_F = 11 \text{ A}, V_{GS} = 0,$ $di_F/dt = 100 \text{ A}/\mu\text{s}$

Note: 1. Pulse test

See characteristic curves of 2SK1159, 2SK1160.





Unit: mm

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Semiconductor & Integrated Circuits. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

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For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose CA 95134 Tel: <1> (408) 433-1990 Fax: <1>(408) 433-0223 Hitachi Europe GmbH Electronic components Group Dornacher Stra§e 3 D-85622 Feldkirchen, Munich Germany

Tel: <49 > (89) 9 9180-0 Fax: <49> (89) 9 29 30 00

Hitachi Europe Ltd. Electronic Components Group. Whitebrook Park Lower Cookham Road Maidenhead

Berkshire SL6 8YA, United Kingdom Tel: <44> (1628) 585000 Fax: <44> (1628) 778322

Hitachi Asia Pte. Ltd. 16 Collyer Quay #20-00 Hitachi Tower Singapore 049318 Tel: 535-2100 Fax: 535-1533

Hitachi Asia Ltd. Taipei Branch Office

3F, Hung Kuo Building. No.167, Tun-Hwa North Road, Taipei (105) Tel: <886> (2) 2718-3666 Fax: <886> (2) 2718-8180

Hitachi Asia (Hong Kong) Ltd. Group III (Electronic Components) 7/F., North Tower, World Finance Centre, Harbour City, Canton Road, Tsim Sha Tsui, Kowloon, Hong Kong Tel: <852> (2) 735 9218 Fax: <852> (2) 730 0281 Telex: 40815 HITEC HX

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